## EFFECT OF PRESSURE ON ZINC BLENDE AND WURTZITE STRUCTURES 147



FIG. 12. Log I<sub>0</sub>/I versus wave number for gallium antimonide.

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pressure, which may in part account for the rapid shift in GaAs at high pressure. The minimum pressure at which the band first occurs depends



FIG. 13. Log Io/I versus wave number for zinc telluride.

slightly on the size and preparation of the sample and on the method of loading the sample in the bomb. In general, a higher transition pressure was obtained the smaller and more perfect the sample, and the greater the difference between the height of the sample and the height of the salt pellet between the pistons. Thus, the mechanism of the process is most likely accelerated by imperfections and shear in the sample. GONSER and OKKERSE<sup>(16)</sup> have obtained a phase change of GaSb at temperatures below the melting point

 

 Table 2. Effect of pressure on the disorder transition of semiconductors

Compound	$P(10^{3} \text{ atm}) \text{ for} T_{t} = 27^{\circ} \text{C}^{*}$	$P(10^3 \text{ atm})$ at which band appeared <sup>†</sup>	
ZnS	184±119	Not<180	
ZnSe	$153 \pm 100$	Small at 90	
ZnTe	121± 79	12-45	
GaP	$218 \pm 119$	Not < 50	
GaAs	$188\pm100$	90-120	
GaSb	$130 \pm 70$	60	

\*Calculated using  $\Delta E = 9 \pm 3$  kcal/mole for ZnS, ZnSe, and ZnTe,  $\Delta E = 12 \pm 2$  kcal/mole for GaP, GaAs, and GaSb, and using  $\Delta V = 6-14$  per cent of  $V_m$  in all cases.

<sup>†</sup>Very small peaks were present at lower pressures in the case of ZnTe, GaAs, and GaSb, probably due to impurities included during crystal growth. Microscopic dark specks were originally present in ZnTe, which could act as nucleating centers for phase change.

Table 3. Effect of pressure on the decomposition of semiconductors

Compound	$\Delta E_{\rm dec}^*$ (kcal/mole)	P  for  70.7% decomp. (10 <sup>3</sup> atm)	P  for  0.71% decomp. (10 <sup>3</sup> atm) <sup>†</sup>	$P_{absorb}$ . Peak obs. (10 <sup>3</sup> atm)
Zns	48±5	$1150 \pm 512$	968±568	Not<180
ZnSe	$34 \pm 3$	$641 \pm 313$	$482 \pm 378$	Small at 90
ZnTe	$29 \pm 3$	$445 \pm 217$	$342 \pm 259$	12-45
GaP	$16 \pm 2$	$350 \pm 181$	$204 \pm 242$	Not<50
GaAs	$11 \pm 1$	$209 \pm 102$	$80 \pm 154$	90-120
GaSb	$10\pm$	$152 \pm 75$	$49 \pm 117$	60

\*Ref. (17, 18); GaP and GaAs values assumed proportional to ZnS and ZnSe values, resp.  $\Delta V = 614$  per cent of  $V_m$ .

†Where lower limit is negative, equilibrium decomposition would exceed 0.71 per cent at zero pressure.

‡Peaks did not increase greatly in size until a pressure of 45,000 atm. was reached.

by neutron irradiation, and report that the new form is a glassy solid with the liquid structure and has a volume about 8 per cent less than the normal form. The energy accompanying this process is within several per cent of the heat of fusion.

The absorption at the front of the edge could be due to the formation of this disordered state by pressure or to chemical decomposition. Table 2 shows the calculated range of pressures for melting at room temperature, using reasonable ranges of values for  $\Delta H$  and  $\Delta V$ . Table 3 shows similar results for 70.7 and 0.71 per cent decomposition. GaAs, GaSb and ZnTe all approach the melting pressure in the range where the band appears. Decomposition could also occur in significant amounts in GaAs and GaSb, but this is less likely for ZnTe.

It might be possible to prepare semiconductors or phosphors with controlled and uniform impurity levels by a combined application of pressure and temperature.

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